

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. M122-2495		PRIORITY SERIAL NO. 09/521,092	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Scott E. Moore et al.		PRIORITY FILING DATE March 7, 2000	
					PRIORITY GROUP 3723			
U.S. PATENT DOCUMENTS								
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
	AA							
	AB							
	AC							
	AC							
	AC							
	AC							
	AC							
	AE							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Subclass	Translation	
							Yes	No
	AH							
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)								
	AI	"The Science and Engineering of Microelectronic Fabrication"; Campbell, Stephen A.; Oxford University Press: 1996; pp. 253-257.						
	AI	http://www.intratechnology.com/html/sensors.htm, Intra Technology, Sensors, 03/25/99, 2 pages						
	AI	http://www.fisinc.com/complete/analite/analite.htm, FTS, Analite-SDI Turbidity Sensor, 03/25/99, 1 page						
	AK	http://www.customsensors.com/optimax.htm, Custom Sensors & Technology, OptiMax 6000 Series Process Parametric Analyzers, 03/25/99, 2 pages						
	AL	http://www.reflectronics.com/reflectronics_inc_content.htm, Reflectronics, Inc., Fiber Optic Backscatter Sensor, 03/25/99, 1 page						
	AM	http://www.honeywell.com/sensing/prodinfo/turbidity/technical/turbidity.st, Gary O'Brien, Honeywell, Turbidity Sensor for Electromechanical Dishwasher Control, 1993-1999, 11 pages						
	AT	http://www.impmag.com/O_automa11970054.htm, ABB Instrumentation, The Stockroom, Photodiode Sensor, 1999, 1 page						
EXAMINER					DATE CONSIDERED			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>								